Application/Control No. Applicant(s)/Patent Under Reexamination 10/751,305 HEIN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1762 B. Chen **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 08-1991 US-5,037,517 Randhawa, Harbhajan S. 204/192.15 Α В US-5,522,976 A 06-1996 Campet et al. 204/298.13 С US-4,517,217 05-1985 Hoffman, Richard A. 428/632 US-D US-Ε US-F US-G US-Н US-US-J Κ US-US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

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